From Novel Imaging Sensors to Advanced Tracking Devices

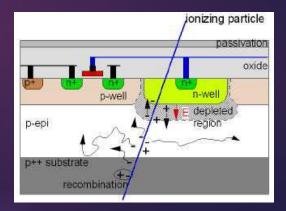
FROM DELPHI AT LEP TO MIMOSIS AT FAIR AND BEYOND

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CONTENT

Monolithic CMOS pixel sensors for charged particle detection: The proof of principle: efficient detection of charged particles Establishing charged particle tracking 1st CMOS sensor based vertex detector in a collider experiment Follow-ups: ALICE-ITS2 at CERN-LHC and CBM-MVD at FAIR/GSI Kernel actors of > 20 years of CMOS sensors developpement Conclusion - Outlook

2024 ICFA INSTRUMENTATION AWARDS



EST&BLISHING & PROOF OF PRINCIPLE SUCIMA

LEP/e+e- coll./HF tagging with HAPS: Delphi: 200x200 μ m²; > 1% X0, > 1 W/cm² > join TESLA collider project on VD (F.Richard)
 > contact LEPSI-Strasbourg: Renato Turchetta

standard VLS technology, NIM A458 (11 Feb. 2001), pp 677-689

MIMOSA I (Minimum Ionising particle MOS Active pixel detector

Simulation and Mensur rements of Charge Collection in Monolithic Active Pixel Sensors

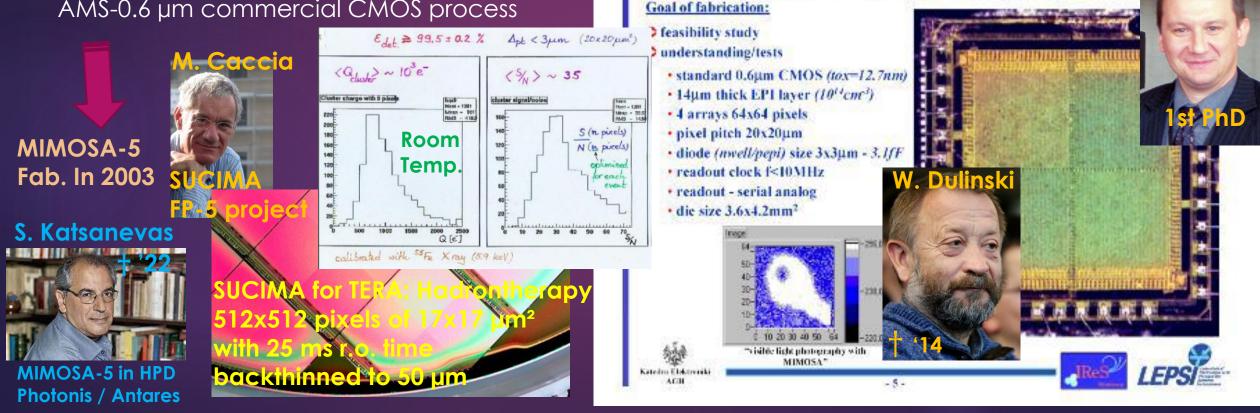


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March '99: 1st talk on MAPS for a VD at ECFA-LC workshop in Oxford

MIMOSA-1: fabricated in 2000 with AMS-0.6 µm commercial CMOS process

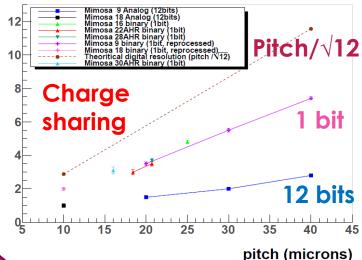


ESTABLISHING CHARGED PARTICLE TRACKING EUDET

O(1) µm resolution exploiting charge sharing → read-out time > 1 ms But a Higgs-Factory Vx Det. requires < 10 µs

 MIMOSA-8 proto. (TSMC-0.25): 2004/5 end of col. discri. (Yavuz Degerli/Saclay)
 → MIMOSA-16/22 proto. (AMS-0.35 OPTO)
 → MIMOSA-26 final sensor (EUDET-FP6): High resolution beam telescope





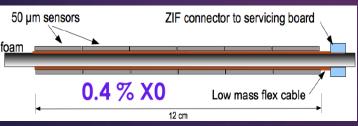
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EUDET Beam Telescope - 2008

Mimosa resolution vs pitch

Numerous applications:

- > 10 BT (DESY, CERN, SLAC, ../)
- Fixed target expts (NA61, ...)
- Hadrontherapy
- Industrial imager
- Research in biology
- PLUME 2-sided ladder



MIMOSA-26: 1024 col. of 512 pixels
2 cm² sensitive area (50 µm thin)
18.4 µm pitch
14-20 µm high-res EPI (no bias)
readout time: 115 µs
end-of col. discri., binary charge encoding, zero-suppression
3.2 µm resolution

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APPLICATION TO A VERTEX DETECTOR COMPOSING A COLLIDER EXPERIMENT

VERTEX 2000

STAR AMS-0.35

A new Inner Vertex Detector for STAR

> H. Wieman Vertex 2000

MONOLITHIC ACTIVE PIXEL SENSORS FOR A LINEAR COLLIDER

(Marc WINTER - IRES (Strasbourg)) on behalf of IRES+LEPSI coll.

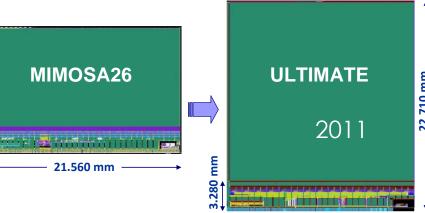
- Physics Motivations

- · Principle of Operation of M.A.P.S.
- · Characteristics of 1st MAPS prototype

780 mm

- . Beam test Results (preliminary)
- Outlook



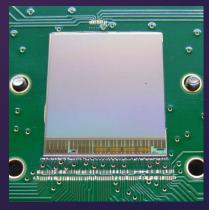


20.240 mm



STAR-PXL: 2 layers (~ 0.4 % X0/layer), 400 ULTIMATE sensors (1600 cm²), back-thinned to 50 μm 170 mW/cm2, air-cooled (10 m/s)

AMS-0.35 OPTO (twin-well process) Customised EPI: 15 μm, High Res. 960 x 928 pixels (pitch = 20.7 μm) Spatial resolution < 4 μm Readout time: 185 μs In-pixel Amp. & Corr. Dble Sampling Deep Reactive Ion Etching (DRIE)



APPLICATION TO AN INNER TRACKER COMPOSING & COLLIDER EXPERIMENT

2010/11: proposal to consider CMOS pixel sensor fo the upgrade of the ALICE vertex detector, based on the same readout architecture (rolling shutter) as MIMOSA-26/-28, customised for the ALICE physics goal & more demanding running conditions

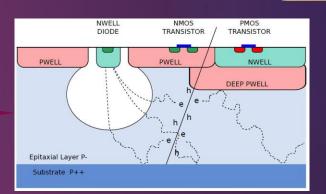
ALICE coll. approved the proposal in 2011/12, promoted by Luciano Musa, who extended the concept to the whole ITS (10 m²)

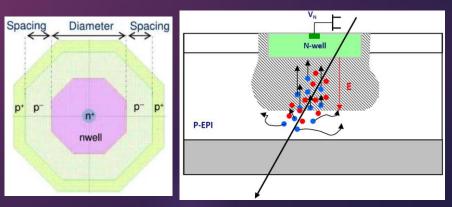
New CMOS process (INMAPS pionnered by Renato T. at RAL):

- Tower-Jazz 180 nm CIS process
- **quadruple well** technology \rightarrow in-pixel P-MOS & N-MOS transistors
- EPI: Thickness = $18/25/30/40 \ \mu m$, -- High-Res. ~ $1-8 \ k\Omega$.cm

PICSEL Team (IPHC-Strasbourg):

- extensive study of the techno. charge coll. & sensing characteristics
- find out an **optimal sensing system** (EPI, diode, etc.)
- design a sensor adapted to the ITS (MISTRAL/ASTRAL)
 - surpassed by ALPIDE, designed by Walter S. (et al.): featuring a superior readout architecture in-pixel discri., priority encoding, faster, low power





ALICE

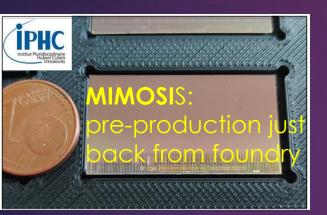


APPLICATION TO A VERTEX DETECTOR COMPOSING A FIXED TARGET EXPERIMENT

March 2003:1st seminar on CMOS pixel sensors at GSI (invited by H. Gutbrod) CBM ≡ H.I. fixed target expt → Micro-Vertex Detector faces very high hit density → more demanding running conditions than ALICE-ITS2

Stretched timeline allowed to benefit from evolution of CMOS industry (Tower-Jazz 180 nm) and progress on CMOS sensor design (ALPIDE, mod. EPI)

Standard EPI



Priority encoder & pixel design derived from ALPIDE EPI layer doping profile modified for improved rad. tol.

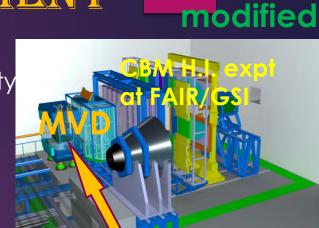
20 yrs of steady support and trust from GSI / Darmstadt & Univ. Goethe / Frankfurt, with highly appreciated collaborators





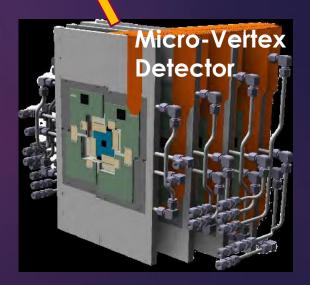
Modified EPI profile

(from Walter S.)



CBM

TJsc-0.18



EXTENSICE STUDY OF KEY PARAMETRES RULING CHARGED PARTICLE DETECTION



Support from IN2P3/CNRS Dir.:

 \rightarrow PICSEL & CMOS sensor devt:

- \approx 10 engineer positions created
- ≥ 6 post-docs, 2 phys. positions
- funding: foundry submissions, test equipment

& Support from IPHC-Strasbourg

Strasbourg PICSEL team (≤ 25 FTE):
3-5 physicists, O(10) ASIC designers,
4-5 electroniciens, ≤ 5 PhD students
> 20 PhDs on CMOS sensor R&D

Essential Partners (incomplete):

- Irfu-CEA (Y.Degerli): end-of-col. discri. (MIMOSA-8)
- DESY/Univ.Hamburg (I.Gregor): EUDET Beam Tel., AIDA
- STAR coll. (Berkeley, BNL): STAR-PXL/HFT
- Univ. Frankfurt (J.Stroth), GSI: CBM-MVD, Hadron-Physics-2
- ALICE-ITS2/CERN (L.Musa): → ALPIDE (Walter S.)

Charge collection & signal sensing:

- EPI: thickness, resistivity doping profile
- junction: dimensions, insulation
- depletion: top vs back vs field amplitude
- impact of/on pixel dimensions
- ISE/TCAD simulations

In-pixel signal processing:

- pre-amp T: size & shape vs gain & RTS
- noise suppression: double-corr. sampling, ...
- junction to preamp: DC vs AC

Read-out architecture:

- charge encoding: binary, ADC (4-5 bits, ...)
- zero-suppression, elastic buffering, ...)

Particle detection performance assessment:

- lab tests: noise, steering param. , threshold dispersion, ...
- beam test: det. eff., cluster characteristics, spatial resol.
- radiation tolerance assessment: TID, NIEL, SEE, ...

Determination of requirements:

- ILC vertex detector and inner tracke
- optimisation of conflicting design param.
- investigate charge coll. system variants

Comparaison of CMOS processes:

- impact of feature size, design rules, IP µcircuits
- planar vs triple-well vs quadruple-well
- nb of ML
- intrinsic radiation tolerance

PICSEL: Physics with Integrated Cmos Sensors and ELectron machines

CONCLUSION & OUTLOOK

My involvement in the birth and devt of CMOS pixel sensors for charged particle tracking stems from an **idea proposed by Renato** and benefited from **R&D realised/supervised by Walter**

Monolithic CMOS Pixel Sensors for charged particle tracking are born 25 years ago. They have evolved in numerous aspects, relying on an industrial market which was not anticipated to preserve characteristics essential for charged particle detection

Toward a future (e+ e-) Higgs Factory:

- the challenge is still to concentrate in a single, thin, low power sensor the ambitionned spatial and time resolution
- on-going & emerging projects pave a promissing path: CBM-MVD (& STS upgrade), ALICE-ITS3 (& eIC expts), Belle-II ?, ALICE-3

Numerous pending questions:

- which CMOS technology: TPSCo 65 nm ?, XXX 28 nm ? ... or TJsc 180 nm ?
- with/without stitching (e.g. what about sensors embedded in mylar foils ?)
- why restricting to processes featuring an EPI layer ?
- what about stacked sensors ?
- etc.



THANK YOU VERY MUCH ?

